Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10594156	FUJIYAMA ET AL.
Examiner	Art Unit

1625

SEARCHED					
Class	Subclass	Date	Examiner		
546	66	6/9/09	CA		
428	917	6/9/09	CA		
546	66	4/2/10	CA		
428	917	4/2/10	CA		
313	498	4/2/10	CA		
136	263	4/2/10	CA		

Charanjit S Aulakh

SEARCH NOTES				
Search Notes	Date	Examiner		
STN STRUCTURE SEARCH, FILE CAPLUS	6/9/09	CA		
ALL INVENTORS NAME SEARCH DONE IN PALM	6/9/09	CA		
REVIEWED AND UPDATED STN STRUCTURE SEARCH DONE ON 6/9/09	4/2/10	CA		
REVIEWED AND UPDATED INVENTORS NAME SEARCH DONE ON 6/9/09	4/2/10	CA		

INTERFERENCE SEARCH				
Class		Subclass	Date	Examiner
546	66		4/2/10	CA
313	498		4/2/10	CA
136	263		4/2/10	CA
428	917		4/2/10	CA

U.S. Patent and Trademark Office Part of Paper No. : 20100402